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Nucleation of Dislocations in 3.9 nm Nanocrystals at High Pressure

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1	Nucleation of Dislocations in 3.9 nm Nanocrystals at High Pressure
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18	Abstract:

19 As circuitry approaches single nanometer length scales, it has become important to predict the stability of single nanometer-sized metals. The behavior of metals at larger scales can be 20 predicted based on the behavior of dislocations, but it is unclear if dislocations can form and be 21 22 sustained at single nanometer dimensions. Here, we report the formation of dislocations within 23 individual 3.9 nm Au nanocrystals under nonhydrostatic pressure in a diamond anvil cell. We used a combination of x-ray diffraction, optical absorbance spectroscopy, and molecular dynamics simulation to characterize the defects that are formed, which were found to be surfacenucleated partial dislocations. These results indicate that dislocations are still active at single nanometer length scales and can lead to permanent plasticity.

28

29 Main text:

30 Permanent plastic deformation occurs in bulk crystalline metals that are subjected to large strains 31 at room temperature. This irreversible deformation can be due to the short-range interactions 32 between dislocations, or the formation of dislocation arrays at grain or twin boundaries. 33 Recently, reversible deformation from large strains has been observed in sub-10 nm Ag 34 nanocrystals [1] and 3.9 nm Au nanocrystals, [2] in which the nanocrystal rapidly recovers from 35 a flattened state after load is removed, and reverts to its original faceted shape. The mechanisms 36 behind this behavior remain unclear, as there is evidence for both diffusion and dislocation 37 mediated plasticity. Rapid diffusion of atoms at free surfaces and stress-induced diffusion at the 38 nanocrystal-indenter and nanocrystal-substrate interfaces have been proposed as mechanisms, 39 based on theoretical considerations and in situ transmission electron microscope (TEM) 40 observations [1,3]. Others have instead observed surface-nucleated dislocations and deformation 41 twinning in sub-10 nm nanowires, and stacking faults tetrahedra in sub-20 nm nanowires under 42 tension in both experiments and molecular dynamics (MD) simulations [4–7]. Dislocations and 43 diffusion may also act cooperatively. In situ TEM tension tests on ~20 nm and sub 5 nm Ag 44 nanowires showed that surface diffusion is enhanced at surface steps created by the passage of 45 dislocations [8,9]. Previous work from our group showed that pseudoelastic shape recovery

46 (diffusion mediated process) in 3.9 nm Au nanocrystals is accompanied by the formation of
47 irreversible defects, but the nature of the defects could not be determined [2].

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48 These observations prompt the questions: Is there a limit to plasticity at small length 49 scales? What is the smallest crystal in which dislocations can form and lead to irreversible 50 deformation? This is critical to the processing and mechanical behavior of nanostructured 51 materials such as nanocrystalline, nanotwinned and nanoporous metals, and the design of stable 52 nano-devices with single nanometer metallic features [10]. To answer these questions, 53 deformation mechanisms in very small nanocrystals must be experimentally determined, but this 54 remains challenging. In situ TEM mechanical testing is the leading method to investigate 55 deformation mechanisms at this length scale, but results may be influenced by heating from the 56 electron beam. In addition, fast dislocations and dislocations that are invisible at specific imaging 57 conditions cannot be observed. X-ray diffraction (XRD) is another method to measure elastic 58 strain and defect formation in metals under mechanical stress. The width and relative intensities 59 of XRD peaks have previously been used to detect dislocation activity in nanocrystalline Ni 60 under uniaxial tension [11] and compression in a diamond anvil cell (DAC) [12]. These studies 61 involve the response at grain boundaries as well as within the grains, so they cannot be directly 62 applied to understand plasticity in individual nanocrystals. To do this, the structural response of 63 isolated nanocrystals must be obtained. This presents a challenge for in situ XRD because the 64 diffracted intensities from a single nanocrystal are much too small for detection.

Here, we use XRD to detect structural changes in an ensemble of monodisperse 3.9 nm Au nanocrystals that are compressed under a non-hydrostatic pressure in a DAC. Surfaces of the nanocrystals are protected by organic ligands, which prevents contact between the nanocrystals. Structural changes from XRD are corroborated with optical spectroscopy measurements, and

69 MD simulations are used to determine the specific defects that correspond to the ensemble-70 averaged behavior from XRD. We show that irreversible deformation due to the formation of 71 surface nucleated partial dislocations can occur in small metallic nanocrystals. This indicates that 72 dislocation-mediated plasticity is still active at single nanometer length scales and must be 73 considered in designing structures at this scale. In addition, a transition from collective to 74 localized dislocation nucleation events has been observed in theoretical studies of homogenous 75 dislocation nucleation [13,14], which can be compared to the DAC compression of extremely small nanocrystals. These concepts have been tested using nanoindentation, but DAC 76 77 compression allows the examination of smaller samples under various stress states using in-situ 78 measurement techniques.

79 Au nanocrystals were synthesized using the organic phase reduction of chloroauric acid 80 and capped with dodecanethiol ligands [15]. The nanocrystal size distribution was found to be 81 3.9±0.6 nm using TEM (see Fig. 1A and see the Supplementary Material [16]). High-resolution 82 TEM images showed that most of the identified nanocrystals were either icosahedral or 83 decahedral in shape (Fig. 1B-C). Icosahedral nanocrystals have 20 twin boundaries, and 84 decahedral nanocrystals have 5 twin boundaries. Ambient pressure XRD showed an FCC crystal 85 structure, and significantly broader peaks than bulk Au due to the limited coherent scattering 86 volume within the nanocrystals (see the Supplementary Material [16]). The (111), (220), (311) and (222) XRD peaks were shifted to higher 2 θ angles by ~0.1° compared to that of the bulk, 87 88 which corresponds to a $\sim 1.8\%$ volumetric compressive strain. The position of the (200) peak was 89 shifted to lower 2 θ angles by 0.15°. Broad shoulders were observed on the (200) and (220) peaks. 90 These features are indicative of the high twin density in icosahedral and decahedral 91 nanocrystals [24]. In addition, the (111) peak showed asymmetric broadening due to tensile and

92 compressive stresses at the surfaces and the interior of the nanocrystals due to surface 93 stresses [32]. The Au nanocrystals consist of ~20% surface atoms with most of the surface 94 covered with (111) planes. As a result, the (111) peak shows the most asymmetrical broadening 95 compared to the other peaks. The Debye scattering equation was used to fit the XRD pattern to 96 determine the structure of the nanocrystals. In this method, the atomic positions for icosahedral 97 and decahedral nanocrystals were generated for 1 to 6 nm diameter nanocrystals and used to 98 simulate XRD patterns. A Rietveld-like refinement procedure was used to fit the experimental 99 data [24,26]. The best fit was obtained by combining 60% icosahedral nanocrystals with a size 100 distribution of 3.2 ± 0.2 nm and 40% decahedral nanocrystals with a size distribution of 3.8 ± 0.6 101 nm (see the Supplementary Material [16]). This result is in close agreement with the nanocrystal 102 shape and size distribution observed in TEM.

103 High pressure XRD was obtained during DAC compression experiments at the Advanced 104 Light Source at Lawrence Berkeley National Laboratory (Fig. 2A-B). A non-hydrostatic pressure 105 was applied to the nanocrystals by loading the nanocrystals as a thick film at the bottom of the 106 DAC sample chamber, and using toluene as a non-hydrostatic pressure medium [33]. XRD was 107 collected while the nanocrystals were loaded up to 7.5 GPa and as pressure was released. The 108 pressure was limited to 7.5 GPa to avoid sintering between the nanocrystals, which has been 109 observed by our group and others at higher pressures [34-36]. The XRD peak position and 110 width (full width at half max) were observed to change with increasing and decreasing pressure 111 and quantified at each pressure (Fig. 2C-D). The relative intensity of the XRD peaks does not 112 change under pressure, which indicates that the nanocrystals remain randomly oriented.

113 The change in peak position indicates the elastic strain in the nanocrystals. The shift in 114 the peak position shows that the lattice spacing decreases by 0.042 Å over 7.5 GPa and recovers 115 to $\sim 0.2\%$ of its original value upon unloading. The (200) peak position gives information about 116 the extent of twinning in the sample (see Fig. S8 for the qualitative effect of twinning on the 117 XRD peak). The complete recovery of the (200) peak position indicates that the initial multiply 118 twinned structure (icosahedral/decahedral) is preserved after the pressure cycle. Due to the non-119 hydrostatic pressure, the change in lattice spacing is different along the loading axis (axial) and 120 orthogonal to the loading axis (radial). The geometry of the X-ray setup is such that the 121 measured lattice spacings correspond to planes that are almost aligned with the loading axis. 122 Therefore, the measured change in lattice spacing is lower than in the hydrostatic case (see the 123 Supplementary Material [16]). The difference between radial and axial stress components 124 (termed as t) can give us an estimate of maximum deviatoric and shear stresses in the system. 125 This difference can be calculated by considering the elastic anisotropy of a polycrystalline, FCC 126 metal. We used lattice strain theory to get a rough estimate of 't' [31,37] (see the Supplementary 127 Material [16]). Using this we estimated the maximum shear stress of Au nanoparticles to be 128 about 2.3 GPa (see the Supplementary Material [16]).

129 Fig. 2D shows the change in peak width for the (111), (200) and (220) peaks with a 130 complete pressure cycle. The (200) peak width showed a significant increase of 16% and the 131 (220) peak width showed an increase of 23% with increasing pressure and remained at higher 132 values after unloading. This indicates that irreversible deformation is occurring in the 133 nanocrystals and remains in the nanocrystals on the time scale of the experimental 134 measurements. The XRD peak width can be affected by changes in crystallite size, shape and 135 microstrain [38]. It is possible that crystalline domains within the nanocrystal become elongated 136 under compression and split into smaller domains, but post-compression TEM images showed 137 that the nanocrystal shape and size distribution is identical to that of the as-synthesized

138 nanocrystals (see the Supplementary Material [16]). The (111) peak width is mostly affected by 139 domain size changes and is least affected by the presence of defects like twinning and stacking 140 faults in the nanocrystal (see the Supplementary Material [16]). The peak width for (111) peak 141 remained at about 2% of its initial value with pressure cycling. The insignificant change in the 142 (111) peak width also indicates that domain size does not change under pressure [24,39]. From 143 this analysis, we determine that the increased peak width after unloading is caused by the 144 formation of crystalline defects such as dislocations rather than changes in the size and shape of 145 crystalline domains. The observation that (200) and (220) peak were the most affected and the 146 (111) peak is least affected indicates the presence of stacking faults, twinning and dislocations 147 (see the Supplementary Material [16]).

148 These XRD results were corroborated by high-pressure optical absorbance spectroscopy. 149 Au nanocrystals have a plasmonic resonance that is dependent upon nanocrystal size, shape and 150 microstructure [40]. Previous optical modeling showed that the plasmon peak wavelength is 151 indicative of nanocrystal shape, while an irreversible decrease in the plasmon peak intensity is 152 indicative of the formation of crystalline defects [2]. The plasmon peak wavelength of the 3.9 153 nm Au nanocrystals increased by ~30 nm when pressure was increased to 7.5 GPa and recovered 154 its initial value upon unloading (see the Supplementary Material [16]). These optical 155 measurements showed that the nanocrystals elongate into ellipsoids and then recover their 156 original shape after unloading. The plasmon peak intensity showed an irreversible decrease after 157 unloading. The reduced absorbance peak intensity after unloading is correlated to the formation 158 of defects in nanocrystals through a damping factor [2]. The optical data supports the conclusion 159 that the irreversible increase in XRD peak width after pressure cycling is due to the formation of 160 crystalline defects, rather than a change in the size and shape of crystalline domains within the

nanocrystals. UV-vis absorbance provides conclusive information about nanocrystal shape, and
 XRD provides conclusive information about defect formation.

163 MD simulations were used to understand the crystalline defects that form within the 164 nanocrystals, and their interactions with existing twin boundaries and surfaces. Two types of 165 stacking faults (SF) were formed in an icosahedral nanocrystal under pressure (Fig. 3A); SF type 166 1 refers to a stacking fault parallel to the outer surface of the nanocrystal (or parallel to surface 167 steps formed during deformation), and SF type 2 is a stacking fault parallel to an internal twin 168 boundary that intersects with two other twin boundaries. Both types of stacking fault were 169 formed by the nucleation and propagation of a Shockley partial dislocation with a Burgers vector of $\frac{1}{6}\langle 112\rangle a$. SF type 1 forms when a Shockley partial dislocation with Burgers vector parallel to 170 171 the outer surface propagates on a slip plane parallel to the outer surface. This results in a 172 displacement relative to adjacent grains that is about the magnitude of the Burgers vector (see the 173 Supplementary Material [16]). When trailing partials are activated on the same plane, the 174 stacking fault is removed, which results in the formation of a larger displacement. The trailing 175 partial slip in one grain sometimes triggers stacking fault formation in an adjacent grain. This 176 occurs if the Burgers vector of the trailing partial dislocation (i.e. the slip direction) is aligned 177 well with the Burgers vector of a leading partial dislocation (Fig. 3B). SF type 2 is a dislocation 178 that has a Burgers vector parallel to an interior twin boundary. The passage of SF type 2 is blocked by intersecting twin boundaries and forms interfacial dislocations with a $\frac{1}{9}(222)a$ 179 180 Burgers vector. This type of stacking fault has also been observed in penta-twinned silver 181 nanowire with >40 nm diameter [41]. In contrast to the penta-twinned silver nanowires, the 182 trailing partial does not follow the leading partial (or, the SF type 2) in the 3.9 nm nanocrystal 183 because the image stress is very large due to the proximity to the free surface and opposes the

184 motion of the trailing partial. For this reason, SF type 2 is harder to form, and the plastic 185 deformation of the nanocrystal is dominated by the successive formation of SF type 1 defects. 186 This is in contrast with work by Sun et al. on Ag nanocrystals where they reported liquid like 187 deformation via surface diffusion; however, they had performed very high temperature MD 188 simulations to observe diffusion activity in MD time scale [1]. We conducted room-temperature 189 MD simulations where surface diffusion was limited. This is in line with experiments where the 190 Au nanocrystal surface was protected by bulky organic ligands that form Au-SR bonds which 191 prevent diffusion at the nanocrystal surface [42].

192 We attribute the irreversible deformation in the nanocrystals to SF type 1 defects, as 193 portions of these defects remain in the simulated nanocrystal after unloading (See Fig. 3B). The 194 stacking fault parallel to the outer surface is energetically meta-stable, because of the finite 195 energy barrier required to form a partial dislocation to reversely sweep out the stacking fault. In 196 experimental time scales, some meta-stable stacking faults can be expected to remain. In 197 contrast, SF type 2 escapes quickly to the free surface during unloading upon the removal of 198 deviatoric stress, which implies that the plastic deformation by this type of stacking fault is 199 reversible. SF type 2 forms a partial dislocation loop that is blocked by twin boundaries. This is 200 an unstable structure that is easily pulled towards the free surface by an image stress [41].

The correspondence between the experimental data and MD simulation was evaluated by generating XRD patterns from the MD simulated structures at different pressures by using the Debye scattering equation [26] (see Fig. 4A-B). The Debye scattering equation is a Fourier transform of the interatomic distances in a nanocrystal. Large ripples are observed in the computed patterns due to the small number of atoms in a finite sized nanocrystal (see Fig. S10). These ripples become less prominent when diffraction patterns for different sized nanocrystals

207 are combined. Figure 4 shows the average XRD pattern for 3.5, 3.9, and 4.5 nm icosahedral and 208 4 nm decahedral nanocrystals to mimic the experimental nanocrystal size distribution. A small 209 ripple to the left of (111), and to the right of (200) and (220) can still be observed in Figure 4. 210 While these ripples could be further smoothened by simulating the same nanocrystal size 211 distribution as in experiments, this is infeasible due to constraints on computing time. The XRD 212 peaks were fitted using Lorentzian and Gaussian peak profile with a high order polynomial for 213 the background. Due to the ripple on the (220) peak, the exact (220) peak width cannot be 214 obtained but can still be analyzed qualitatively. The XRD peak width for the simulated patterns 215 showed a similar trend to experimental data in that the (111) peak width broadened the least, and 216 the (200) peak broadened the most under pressure (Fig. 4C-D). The (220) peak width also 217 increased, similarly to experiments (Fig. S11). The effect of adding stacking faults to the 218 nanocrystal is evident from the significant increase of peak width for the (200) and (220) peaks. 219 The close agreement of MD simulated XRD patterns and experimental XRD patterns shows that 220 MD simulations are a true representation of experiments.

221 In summary, using high-pressure XRD, optical absorbance spectroscopy and MD 222 simulations we provide the first evidence of plastic deformation in individual 3.9 nm Au 223 nanocrystals. The plastic deformation governed was by stacking faults formed via surface 224 nucleated partial dislocations. The formation of surface steps during the passage of sequential 225 partial dislocations as well as remaining stacking faults led to residual defects in the nanocrystal. 226 The kinetics of residual defect recovery after unloading the sample will be explored further in 227 future studies. This work provides a critical advancement in using experimental and simulation 228 generated XRD as a comprehensive measurement technique to study defect formation in 229 nanomaterials.

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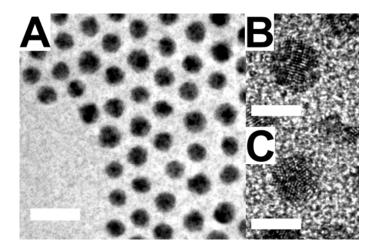
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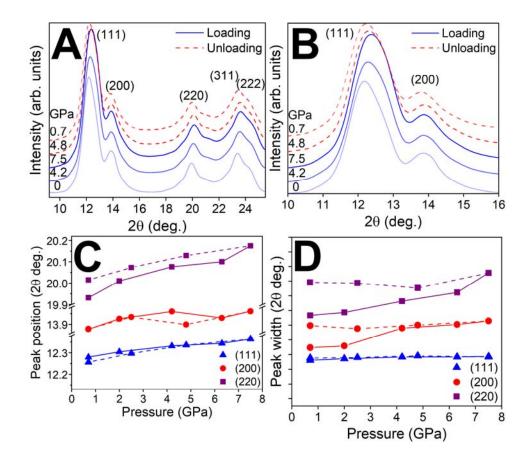
313 Figures



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Fig. 1. TEM images of nanocrystals. A) Monodisperse 3.9 nm Au nanocrystals. Scale bar is 10

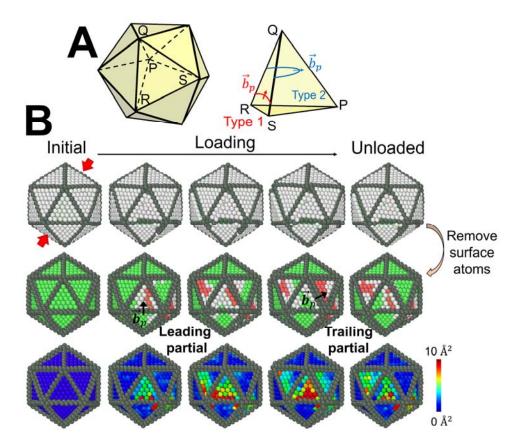
316 nm. High-resolution images of B) icosahedral and C) decahedral nanocrystals. Scale bar is 4 nm.



319 Fig. 2. Experimental high-pressure XRD patterns. A) All diffraction peaks and B) magnified

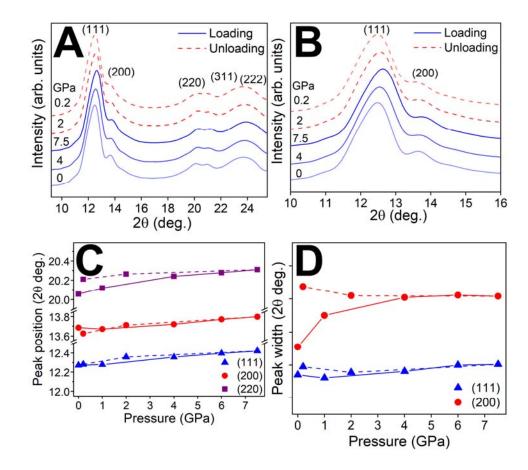
320 view of (111) and (200) peaks. Change in diffraction peak C) position and D) width (each

321 division is 0.1°), upon loading (solid line) and unloading (dashed line).



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Fig. 3. MD simulation of a 3.9 nm icosahedral nanocrystal. A) Schematic of nanocrystal 323 324 geometry and slip planes for stacking fault type 1 and type 2. B) Atomic configurations during 325 loading and unloading process. Top row shows the surface atoms and the loading direction (red 326 arrows). In the next two rows, outermost atoms are omitted to visualize the formation of defects. 327 Images in middle row have green atoms for FCC, white atoms for unclassified crystal structure 328 (typically near the core of a partial dislocation or at the surface), and red atoms for HCP. Images 329 in bottom row are colored according to non-affine squared displacement, in which the slip plane 330 swept by a perfect dislocation is identified.



333 Fig. 4. Simulated high-pressure XRD patterns from MD simulations. A) All diffraction

peaks and B) magnified view of (111) and (200) peaks. Change in diffraction peak C) position

and D) width (each division is 0.1°), upon loading (solid line) and unloading (dashed line).

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